

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

# SSM3K15FS

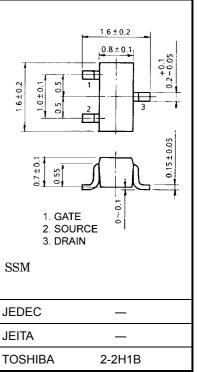
High Speed Switching Applications Analog Switching Applications

- Compact package suitable for high-density mounting
- Low ON-resistance  $: R_{on} = 4.0 \Omega (max) (@V_{GS} = 4 V)$

: Ron = 7.0  $\Omega$  (max) (@VGS = 2.5 V)

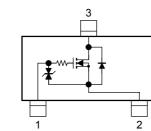
#### Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit	
Drain-Source voltage		V <sub>DS</sub>	30	V	
Gate-Source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC	I <sub>D</sub>	100	mA	
	Pulse	I <sub>DP</sub>	200		
Drain power dissipation (Ta = $25^{\circ}$ C)		PD	100	mW	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight: 2.4 mg (typ.)

## Marking



**Equivalent Circuit** 

#### **Handling Precaution**

3

DΡ

2

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

Unit: mm

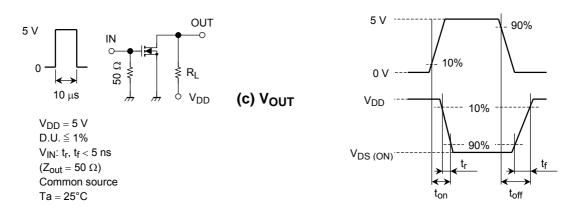
**Electrical Characteristics (Ta = 25°C)** 

Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS}=\pm 16~V,~V_{DS}=0$			±1	μA
Drain-Source breakdown voltage		V (BR) DSS	$I_D = 0.1 \text{ mA}, V_{GS} = 0$	30	_	_	V
Drain Cut-off current		I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0$	_	_	1	μA
Gate threshold voltage		V <sub>th</sub>	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	0.8		1.5	V
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 10 \text{ mA}$	25			mS
Drain-Source ON resistance		R <sub>DS (ON)</sub>	$I_{D} = 10 \text{ mA}, V_{GS} = 4 \text{ V}$		2.2	4.0	Ω
			$I_D = 10 \text{ mA}, V_{GS} = 2.5 \text{ V}$		4.0	7.0	
Input capacitance		C <sub>iss</sub>	$V_{DS} = 3 V, V_{GS} = 0, f = 1 MHz$		7.8		pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 3 V, V_{GS} = 0, f = 1 MHz$		3.6		pF
Output capacitance		C <sub>oss</sub>	$V_{DS} = 3 V, V_{GS} = 0, f = 1 MHz$	_	8.8		pF
Switching time	Turn-on time	t <sub>on</sub>	$V_{DD} = 5 \text{ V}, \text{ I}_{D} = 10 \text{ mA}, V_{GS} = 0 \sim 5 \text{ V}$	_	50		ns
	Turn-off time	t <sub>off</sub>			180		

# **Switching Time Test Circuit**

(a) Test circuit

(b) V<sub>IN</sub>



## Precaution

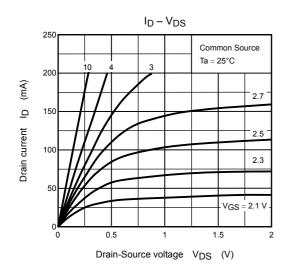
 $V_{th}$  can be expressed as voltage between gate and source when low operating current value is ID = 100  $\mu A$  for this product. For normal switching operation,  $V_{GS}$  (on) requires higher voltage than  $V_{th}$  and  $V_{GS}$  (off) requires lower voltage than  $V_{th}$ .

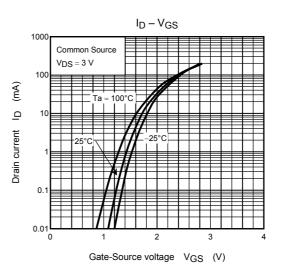
(relationship can be established as follows:  $V{\rm GS}~({\rm off}) < V{\rm th} < V{\rm GS}~({\rm on})$  )

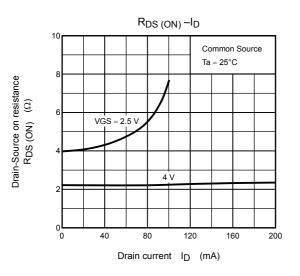
Please take this into consideration for using the device.

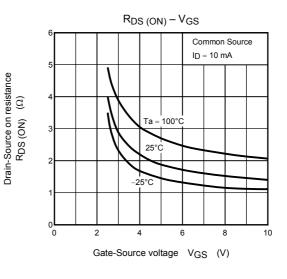
 $\mathrm{VGS}$  recommended voltage of 2.5 V or higher to turn on this product.

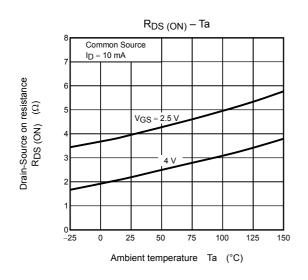
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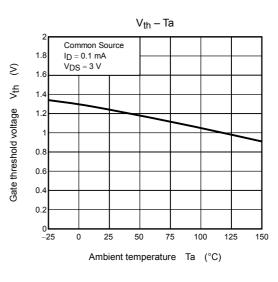




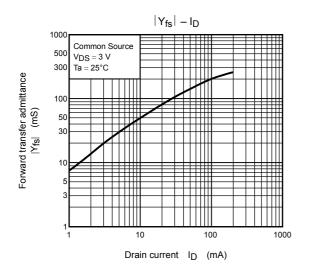


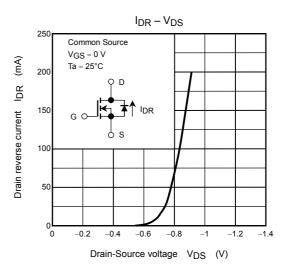


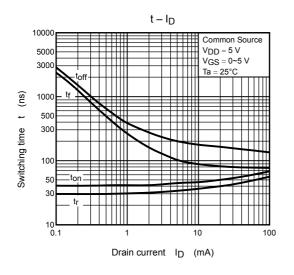


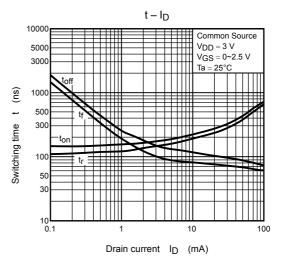


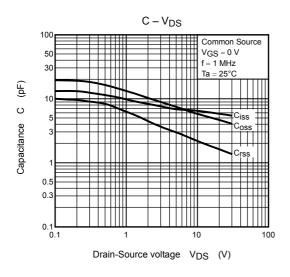
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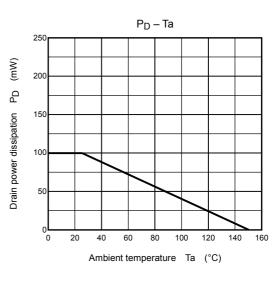












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Handbook" etc.,

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